

General Description

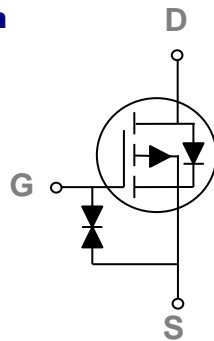
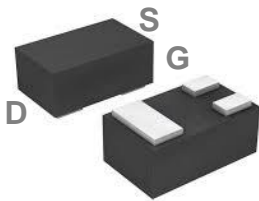
These P-Channel enhancement mode power field effect transistors are using trench DMOS technology. This advanced technology has been especially tailored to minimize on-state resistance, provide superior switching performance, and withstand high energy pulse in the avalanche and commutation mode. These devices are well suited for high efficiency fast switching applications.

BVDSS	RDSON	ID
-30V	1100mΩ	-400mA

Features

- -30V,-400mA, $R_{DS(ON)} = 1100m\Omega @ V_{GS} = -4.5V$
- Fast switching
- Green Device Available

SOT883 Pin Configuration



Applications

- Notebook
- Smartphone
- Battery Protection
- Hand-held Instruments

Absolute Maximum Ratings $T_A=25^\circ\text{C}$ unless otherwise noted

Symbol	Parameter	Rating	Units
V_{DS}	Drain-Source Voltage	-30	V
V_{GS}	Gate-Source Voltage	± 12	V
I_D	Drain Current – Continuous ($T_A=25^\circ\text{C}$)	-400	mA
	Drain Current – Continuous ($T_A=70^\circ\text{C}$)	-302	mA
I_{DM}	Drain Current – Pulsed ¹	-1600	mA
P_D	Power Dissipation ($T_A=25^\circ\text{C}$)	155	mW
	Power Dissipation – Derate above 25°C	1.25	mW/ $^\circ\text{C}$
T_{STG}	Storage Temperature Range	-55 to 150	$^\circ\text{C}$
T_J	Operating Junction Temperature Range	-55 to 150	$^\circ\text{C}$

Thermal Characteristics

Symbol	Parameter	Typ.	Max.	Unit
$R_{\theta JA}$	Thermal Resistance Junction to ambient	---	800	$^\circ\text{C}/\text{W}$

Electrical Characteristics ($T_J=25\text{ }^\circ\text{C}$, unless otherwise noted)
Off Characteristics

Symbol	Parameter	Conditions	Min.	Typ.	Max.	Unit
BV_{DSS}	Drain-Source Breakdown Voltage	$V_{GS}=0V, I_D=-250\mu A$	-30	---	---	V
I_{DSS}	Drain-Source Leakage Current	$V_{DS}=-30V, V_{GS}=0V, T_J=25^\circ\text{C}$	---	---	-1	μA
		$V_{DS}=-24V, V_{GS}=0V, T_J=125^\circ\text{C}$	---	---	-10	μA
I_{GSS}	Gate-Source Leakage Current	$V_{GS}=\pm 12V, V_{DS}=0V$	---	---	± 25	μA

On Characteristics

$R_{DS(ON)}$	Static Drain-Source On-Resistance	$V_{GS}=-4.5V, I_D=-0.2A$	---	780	1100	$m\Omega$
		$V_{GS}=-2.5V, I_D=-0.1A$	---	1160	1600	
$V_{GS(th)}$	Gate Threshold Voltage	$V_{GS}=V_{DS}, I_D=-250\mu A$	-0.5	-0.75	-1.2	V

Dynamic and switching Characteristics

Q_g	Total Gate Charge ^{2,3}	$V_{DS}=-15V, V_{GS}=-4.5V, I_D=-0.3A$	---	3.12	6.2	nC
Q_{gs}	Gate-Source Charge ^{2,3}		---	1.3	2.6	
Q_{gd}	Gate-Drain Charge ^{2,3}		---	0.5	1	
$T_{d(on)}$	Turn-On Delay Time ^{2,3}	$V_{DD}=-15V, V_{GS}=-4.5V, R_G=6\Omega$ $I_D=-0.3A$	---	7.4	15	ns
T_r	Rise Time ^{2,3}		---	21.5	43	
$T_{d(off)}$	Turn-Off Delay Time ^{2,3}		---	46.9	92	
T_f	Fall Time ^{2,3}		---	14.4	29	
C_{iss}	Input Capacitance	$V_{DS}=-15V, V_{GS}=0V, F=1\text{MHz}$	---	73.4	146	pF
C_{oss}	Output Capacitance		---	19.1	38	
C_{rss}	Reverse Transfer Capacitance		---	12.1	25	

Drain-Source Diode Characteristics and Maximum Ratings

Symbol	Parameter	Conditions	Min.	Typ.	Max.	Unit
I_S	Continuous Source Current	$V_G=V_D=0V, \text{Force Current}$	---	---	-400	mA
I_{SM}	Pulsed Source Current		---	---	-800	mA
V_{SD}	Diode Forward Voltage	$V_{GS}=0V, I_S=-0.3A, T_J=25^\circ\text{C}$	---	---	-1	V

Note :

1. Repetitive Rating : Pulsed width limited by maximum junction temperature.
2. The data tested by pulsed , pulse width $\leq 300\mu s$, duty cycle $\leq 2\%$.
3. Essentially independent of operating temperature.

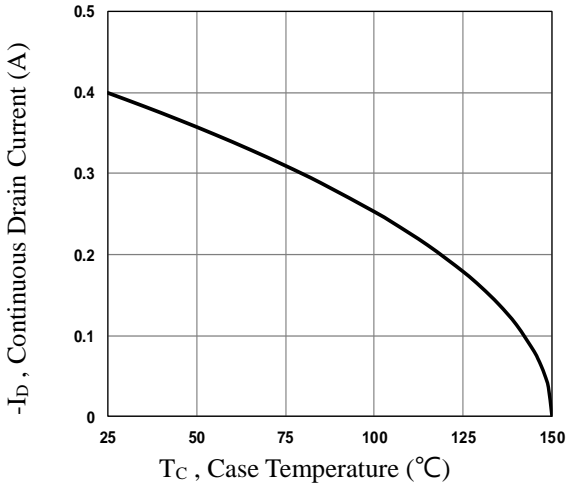


Fig.1 Continuous Drain Current vs. T_c

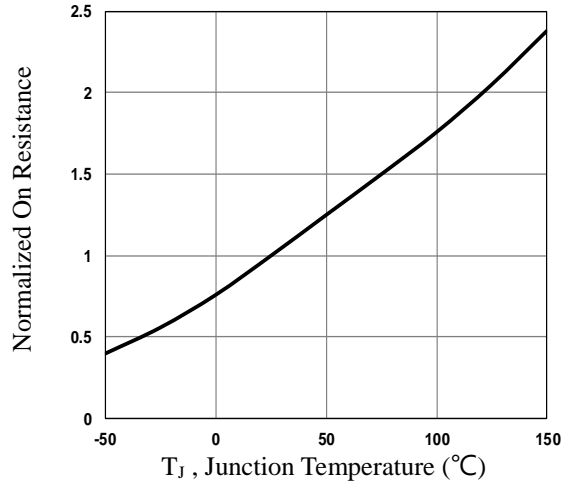


Fig.2 Normalized $R_{DS(on)}$ vs. T_j

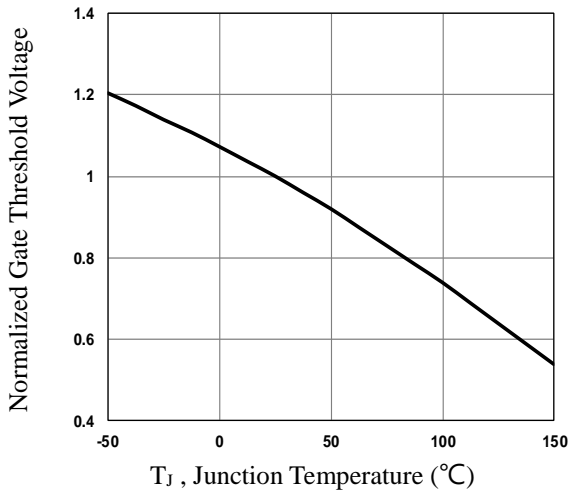


Fig.3 Normalized V_{th} vs. T_j

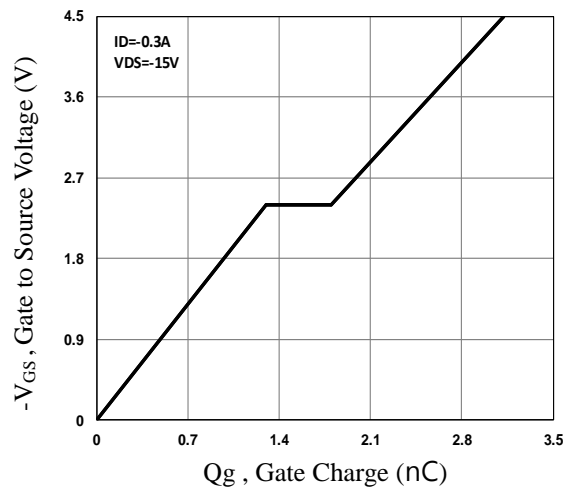


Fig.4 Gate Charge Waveform

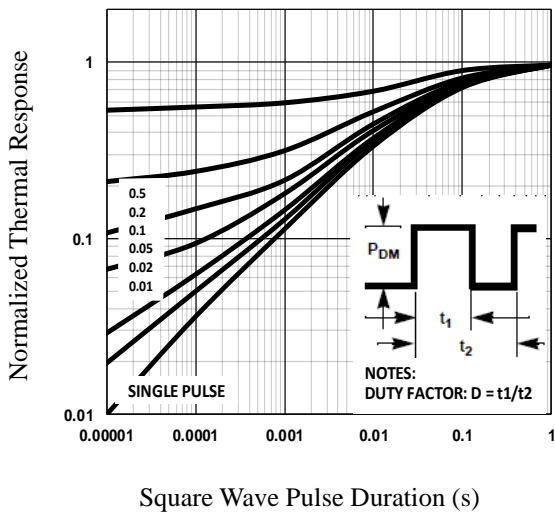


Fig.5 Normalized Transient Impedance

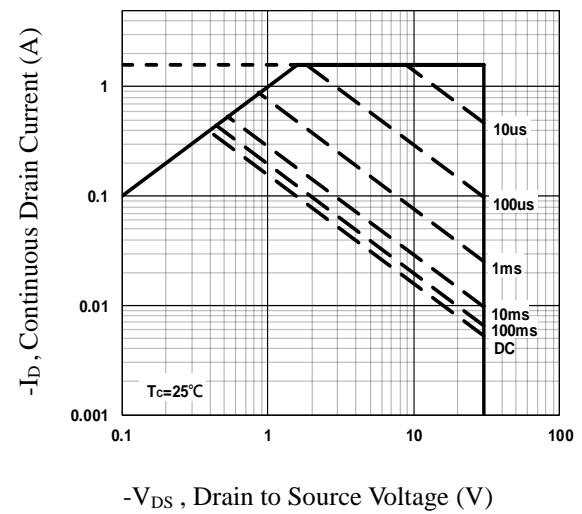


Fig.6 Maximum Safe Operation Area

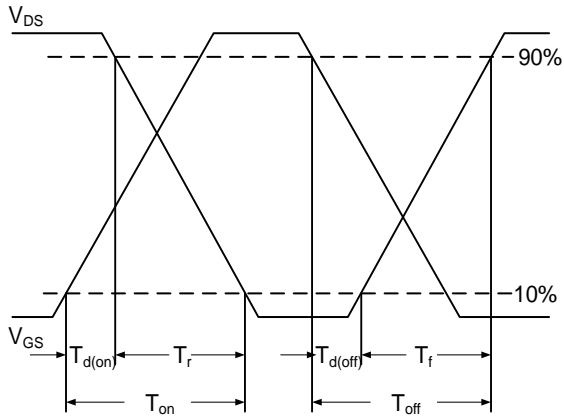


Fig.7 Switching Time Waveform

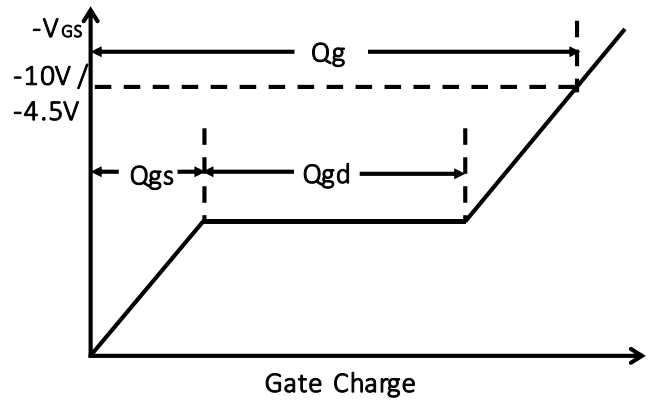
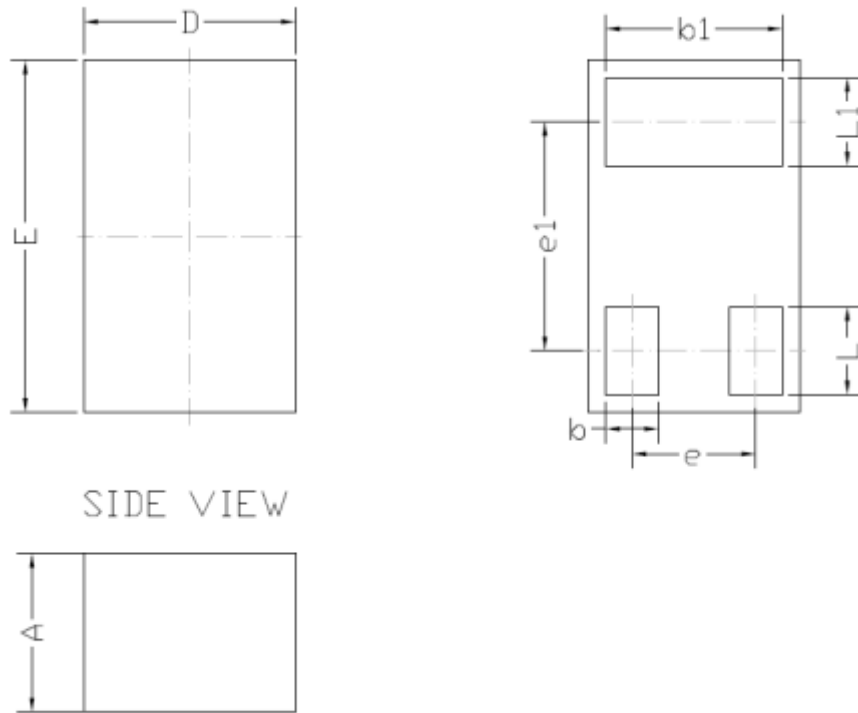


Fig.8 Gate Charge Waveform

SOT883 PACKAGE INFORMATION



Symbol	Dimensions In Millimeters		Dimensions In Inches	
	MAX	MIN	MAX	MIN
A	0.500	0.350	0.020	0.013
D	0.650	0.550	0.026	0.021
E	1.050	0.950	0.041	0.037
e	0.350 BSC		0.014 BSC	
e1	0.650 BSC		0.026 BSC	
b	0.200	0.100	0.008	0.004
b1	0.550	0.450	0.022	0.018
L	0.300	0.200	0.012	0.008
L1	0.300	0.200	0.012	0.008